

<b>Issue Classification</b>				Application/Control No.			Applicant(s)/Patent under Reexamination		
				10/686,311			NAGY ET AL.		
				Examiner			Art Unit		
				Rip A. Lee			1713		

ORIGINAL				CROSS REFERENCE(S)					
CLASS	SUBCLASS	CLASS		SUBCLASS (ONE SUBCLASS PER BLOCK)					
526	162	526	171	134	129	160	170	348	348.2
INTERNATIONAL CLASSIFICATION				526	348.5	348.6	351	352	
C 0 8 F	4/52								
C 0 8 F	4/44								
C 0 8 F	4/76								
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	/								
MAY-17-2005 (Assistant Examiner) (Date)				DAVID W. WU S/17/05 DAVID W. WU SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 1700 (Primary Examiner) (Date)				Total Claims Allowed: 16	
(Legal Instruments Examiner) (Date)				O.G. Print Claim(s)		O.G. Print Fig.			
				1		—			

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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5	5	35	65	95	125	155	185
6	6	36	66	96	126	156	186
7	7	37	67	97	127	157	187
8	8	38	68	98	128	158	188
9	9	39	69	99	129	159	189
10	10	40	70	100	130	160	190
11	11	41	71	101	131	161	191
12	12	42	72	102	132	162	192
13	13	43	73	103	133	163	193
	14	44	74	104	134	164	194
14	15	45	75	105	135	165	195
15	16	46	76	106	136	166	196
16	17	47	77	107	137	167	197
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19		49	79	109	139	169	199
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21		51	81	111	141	171	201
22		52	82	112	142	172	202
23		53	83	113	143	173	203
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25		55	85	115	145	175	205
26		56	86	116	146	176	206
27		57	87	117	147	177	207
28		58	88	118	148	178	208
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30		60	90	120	150	180	210